

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HEER ET AL.	
		Examiner Felix J. Nepveux	Art Unit 1617	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,696,169	12-1997	Otsu et al.	514/675
B	US-			
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D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

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N	EP0979033B1	02-2000	EP	Wolfgang et al.	A01N 43/40
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S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
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X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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